Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/035,027	ZHUANG ET AL.	
Examiner	Art Unit	
CHUONG T. HO	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
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370	206			
370	208			
370	210			
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370	H81			
370	H82			
370	310			
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370	329			
370	343			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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WEST (Text rearch,	04/05/06	.CH		
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Consulting with.	04/06/06	CH		
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